



Am6685

Ultra-Fast Voltage Comparator

DISTINCTIVE CHARACTERISTICS

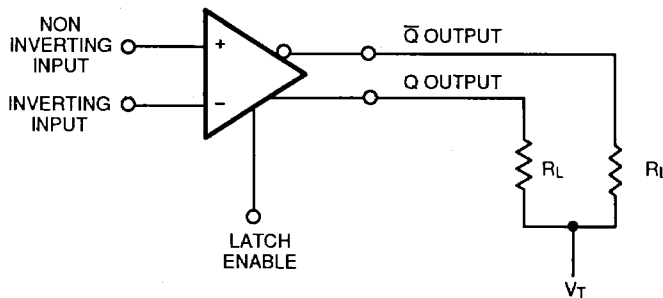
- 2.7 ns typical propagation delay
- Complementary ECL outputs
- 50- Ω line driving capability
- Built-in latch

GENERAL DESCRIPTION

The Am687 is an ultra-fast voltage comparator constructed on a single silicon chip with the advanced IMOX* process. It is pin-for-pin compatible with the Am685, and has improved speed performance. The circuit features very short propagation delays as well as excellent matching characteristics. The circuit has different analog inputs and complementary logic outputs compatible with most forms of ECL. The output current is capable of driving terminated 50-ohm transmission lines. The low-input offsets and short delays make this

comparator especially suitable for high-speed precision analog-to-digital processing. A latch function is provided to allow the comparator to be used in a sample-and-hold mode. The latch input is intended to be driven from a standard ECL gate. If the Latch Enable input is HIGH, the comparator functions normally. When the Latch Enable is driven LOW, the comparator outputs are locked in their existing logical states. If the latch function is not used, the Latch Enable must be connected to ground.

BLOCK DIAGRAM

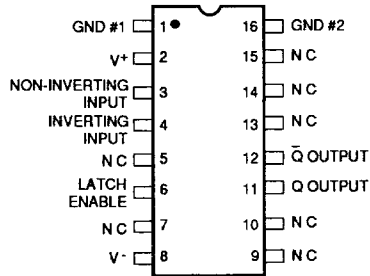


The outputs are open emitters, therefore external pull-down resistors are required. These resistors may be in the range of 50–200 Ω connected to -2.0 V, or 200–2000 Ω connected to -5.2 V.

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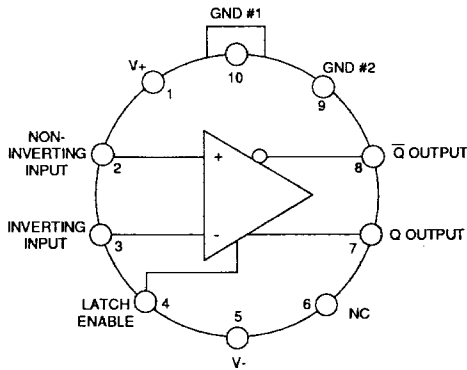
CONNECTION DIAGRAMS Top View

DIP



05975-002

Metal Can



05975-003

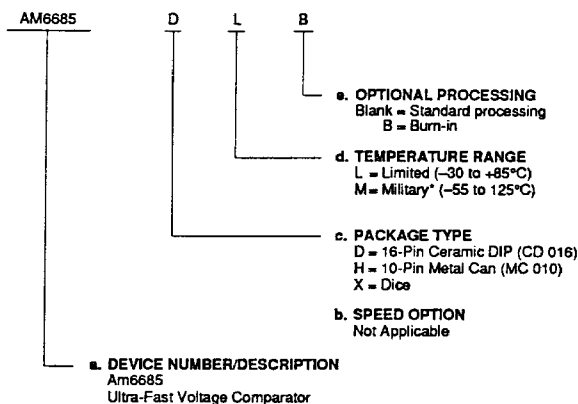
Note: Pin 1 is marked for orientation. On metal package, pin 5 is connected to case; on DIP, pin 8 is connected to case.

ORDERING INFORMATION

Standard Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:

- a. Device Number
- b. Speed Option (if applicable)
- c. Package Type
- d. Temperature Range
- e. Optional Processing



Valid Combinations

* Military or Limited Military temperature range products are "NPL" (Non-Compliant Products List) or Non-MIL-STD-883C compliant products only.

Valid Combinations	
AM6685	DL, DLB, HL, HLB, XL, XM

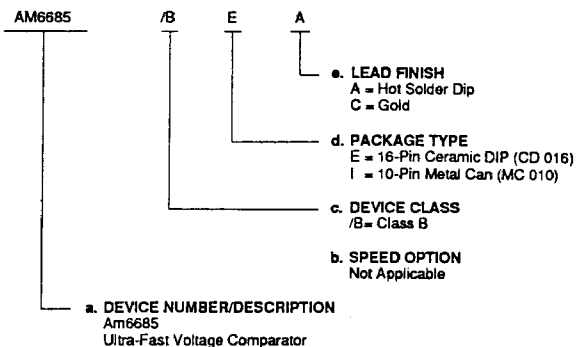
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, to check on newly released combinations, and to obtain additional data on AMD's standard military grade products.

MILITARY ORDERING INFORMATION

APL Products

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883C requirements. The order number (Valid Combination) for APL products is formed by a combination of:

- a. Device Number
- b. Speed Option (if applicable)
- c. Device Class
- d. Package Type
- e. Lead Finish



Valid Combinations

Valid Combinations	
AM6685	/BEA, /BIC

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations or to check on newly released valid combinations.

Group A Tests

Group A tests consist of subgroups 1, 2, 3, 4, 5, 6, 9.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature	-65 to +150°C
Positive Supply Voltage	+7 V
Negative Supply Voltage	-7 V
Input Voltage	±4 V
Differential Input Voltage	±6 V
Output Current	30 mA
Power Dissipation (Note 1)	350 mW
Lead Temperature (soldering, 60 s)	300°C
Minimum Operating Voltage (V+ to V-)	9.7 V

Stresses above those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Limited (L) Devices
Ambient Temperature (T_A) -30 to +85°C

Military (M) Devices
Ambient Temperature (T_A) -55 to +125°C

Operating ranges define those limits between which the functionality of the device is guaranteed.

DC CHARACTERISTICS over operating range unless otherwise specified (for APL Products, Group A, Subgroups 1, 2, 3, 4, 5, 6 are tested unless otherwise noted)

Parameter Symbol	Parameter Description	Test Conditions (Note 2)	LIMITED			MIL			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	
V_{os}	Input Offset Voltage	$RS \leq 100 \Omega$, $T_A = 25^\circ C$	-2.0	0.3	+2.0	-2.0	0.3	+2.0	mV
		$RS \leq 100 \Omega$	-2.5		+2.5	-3.0		+3.0	
$\Delta V_{os}/\Delta T$	Average Tempco of V_{os} (Note 3)	$RS \leq 100 \Omega$	-15	3	+15	-15	3	+15	$\mu V/^\circ C$
I_{os}	Input Offset Current	$25^\circ C \leq T_A \leq T_A$ (Max.)	-1.5	0.2	+1.5	-1.5	0.2	+1.5	μA
		$T_A = T_A$ (Min.)	-2.5	0.3	+2.5	-3.0	0.3	+3.0	
I_b	Input Bias Current	$25^\circ C \leq T_A \leq T_A$ (Max.)		4	15		4	15	μA
		$T_A = T_A$ (Min.)		7	25		8	30	
V_{in}	Input Voltage Range		-3.3		+3.3	-3.3		+3.3	V
CMRR	Common Mode Rejection Ratio	$RS \leq 100 \Omega$, $-3.3 V \leq V_{cm} \leq 3.3 V$	80			80			dB
SVRR	Supply Voltage Rejection Ratio	$RS \leq 100 \Omega$, $\Delta V_s = \pm 5\%$	60			60			dB
V_{OH}	Output HIGH Voltage	$T_A = 25^\circ C$	-0.96	-0.885	-0.81	-0.96	-0.885	-0.81	V
		$T_A = T_A$ (Min.)	-1.06	-0.975	-0.89	-1.1	-1.010	-0.92	
		$T_A = T_A$ (Max.)	-0.89	-0.795	-0.70	-0.85	-0.735	-0.62	
V_{OL}	Output LOW Voltage	$T_A = 25^\circ C$	-1.85	-1.750	-1.65	-1.85	-1.750	-1.65	V
		$T_A = T_A$ (Min.)	-1.89	-1.783	-1.675	-1.91	-1.800	-1.69	
		$T_A = T_A$ (Max.)	-1.825	-1.725	-1.625	-1.81	-1.693	-1.575	

Table continued on next page.

DC CHARACTERISTICS (Cont'd.)

Parameter Symbol	Parameter Description	Test Conditions (Note 2)	LIMITED			MIL			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	
I ₊	Positive Supply Current			12	22		12	22	mA
I ₋	Negative Supply Current			10	18		10	18	mA
P _{DISS}	Power Dissipation (Note 1)			153	254		153	254	mW

Notes: See notes following Switching Characteristics.

DEFINITION OF TERMS

V_{OS} Input Offset Voltage

That voltage which must be applied between the two input terminals through two equal resistances to obtain zero voltage between the two outputs.

ΔV_{OS}/ΔT Average Temperature Coefficient of Input Offset Voltage

The ratio of the change in input offset voltage over the operating temperature range to the temperature range.

I_{OS} Input Offset Current

The difference between the currents into the two input terminals when there is zero voltage between the two outputs.

I_b Input Bias Current

The average of the two input currents.

R_{IN} Input Resistance

The resistance looking into either input terminal with the other grounded.

C_{IN} Input Capacitance

The capacitance looking into either input terminal with the other grounded.

V_{CM} Input Voltage Range

The range of voltages on the input terminals for which the offset and propagation delay specifications apply.

CMRR Common Mode Rejection Ratio

The ratio of the input voltage range to the peak-to-peak change in input offset voltage over this range.

SVRR Supply Voltage Rejection Ratio

The ratio of the change in input offset voltage to the change in power supply voltages producing it.

V_{OH} Output HIGH Voltage

The logic-HIGH output voltage with an external pull-down resistor returned to a negative supply.

V_{OL} Output LOW Voltage

The logic-LOW output voltage with an external pull-down resistor returned to a negative supply.

I₊ Positive Supply Current

The current required from the positive supply to operate the comparator.

I₋ Negative Supply Current

The current required from the negative supply to operate the comparator.

P_{DISS} Power Dissipation

The power dissipated by the comparator with both outputs terminated in 50 Ω to -2.0 V.

SWITCHING CHARACTERISTICS over operating range unless otherwise specified (for APL Products, Group A, Subgroup 9 is tested unless otherwise noted) ($V_{IN} = 100 \text{ mV}$, $V_{OVERDRIVE} = 10 \text{ mV}$)

Parameter Symbol	Parameter Description	Test Conditions (Note 2)	LIMITED			MIL			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	
t_{PD+} , t_{PD-}	Propagation Delay	$T_A = 25^\circ\text{C}$ (Note 3)	2.0	2.7	4.0	2.0	2.7	4.0	ns
$t_{PD+}(E)$, $t_{PD-}(E)$	Latch Enable to Output (HIGH or LOW)	$T_A = 25^\circ\text{C}$ (Note 4)		2.3			2.3		ns
t_S	Min. Latch Setup Time	$T_A = 25^\circ\text{C}$ (Note 4)		1.0			1.0		ns
t_H	Min. Latch Hold Time	$T_A = 25^\circ\text{C}$ (Note 4)		-0.5			-0.5		ns

- Notes: 1. For the metal can package, derate at $6.8 \text{ mW}/^\circ\text{C}$ for operation at ambient temperatures above $+100^\circ\text{C}$; for the dual in-line package, derate at $9 \text{ mW}/^\circ\text{C}$ for operation at ambient temperatures above $+105^\circ\text{C}$.
2. Unless otherwise specified $V_+ = 6.0 \text{ V}$, $V_- = -5.2 \text{ V}$, $V_T = 2.0 \text{ V}$, and $R_L = 50 \Omega$, all switching characteristics are for a 100-mV input step with 10 mV overdrive. The specification given for V_{OS} , I_{OS} , I_B , CMRR, SVRR, t_{PD+} , and t_{PD-} apply for $\pm 5\%$ supply voltages. The Am6685 is designed to meet the specifications given in the table after thermal equilibrium has been established with a transverse air flow of 500 linear feet per minute or greater.
3. Not 100% tested. Group A sample only.
4. Not tested in production. These tests are supported by device characterization data.

DEFINITION OF TERMS

(refer to Switching Waveforms)

t_{PD+} Input to Output HIGH Delay

The propagation delay measured from the time the input signal crosses the input offset voltage to the 50% point of an output LOW-to-HIGH transition.

t_{PD-} Input to Output LOW Delay

The propagation delay measured from the time the input signal crosses the input offset voltage to the 50% point of an output HIGH-to-LOW transition.

$t_{PD+}(E)$ Latch Enable to Output HIGH Delay

The propagation delay measured from the 50% point of the Latch Enable signal LOW-to-HIGH transition to the 50% point of an output LOW-to-HIGH transition.

$t_{PD-}(E)$ Latch Enable to Output LOW Delay

The propagation delay measured from the 50% point of the Latch Enable signal LOW-to-HIGH transition to the 50% point of an output HIGH-to-LOW transition.

t_S Minimum Setup Time

The minimum time before the negative transition of the Latch Enable signal that an input signal change must be present in order to be acquired and held at the outputs.

t_H Minimum Hold Time


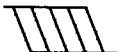


The minimum time after the negative transition of the Latch Enable signal that the input signal must remain unchanged in order to be acquired and held at the outputs.

Other Symbols

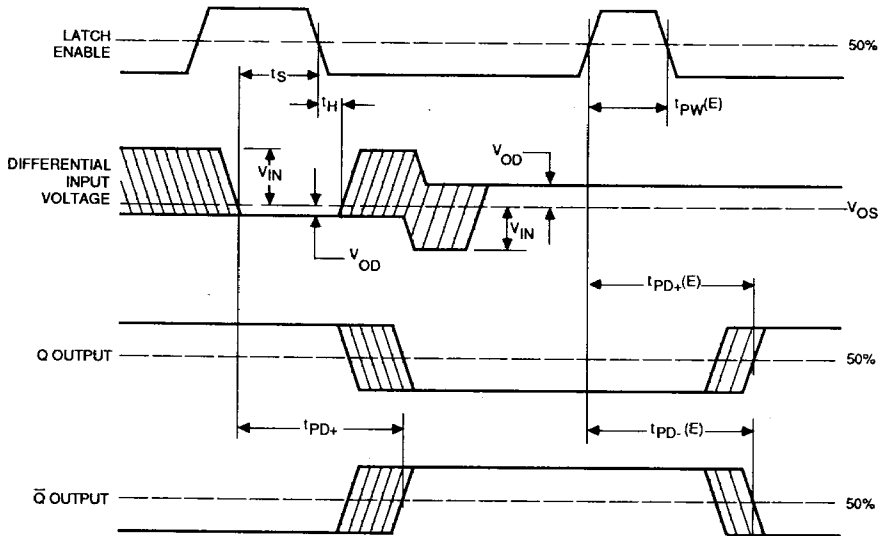
- T_A = Ambient temperature
- R_S = Input source resistance
- V_S = Supply voltages
- V_+ = Positive supply voltage
- V_- = Negative supply voltage
- V_T = Output load terminating voltage
- R_L = Output load resistance
- V_{IN} = Input pulse amplitude
- V_{OD} = Input overdrive
- f = Frequency

SWITCHING WAVEFORMS

KEY TO SWITCHING WAVEFORMS

WAVEFORM	INPUTS	OUTPUTS
	MUST BE STEADY	WILL BE STEADY
	MAY CHANGE FROM H TO L	WILL BE CHANGING FROM H TO L
	MAY CHANGE FROM L TO H	WILL BE CHANGING FROM L TO H
	DON'T CARE, ANY CHANGE PERMITTED	CHANGING, STATE UNKNOWN

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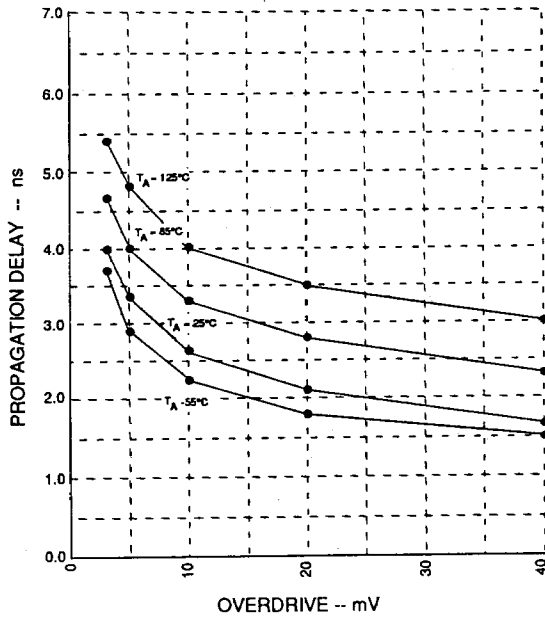
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The setup and hold times are a measure of the time required for an input signal to propagate through the first stage of the comparator to reach the latching circuitry. Input signal

changes occurring before t_s will be detected and held; those occurring after t_h will not be detected. Changes between t_s and t_h may or may not be detected.

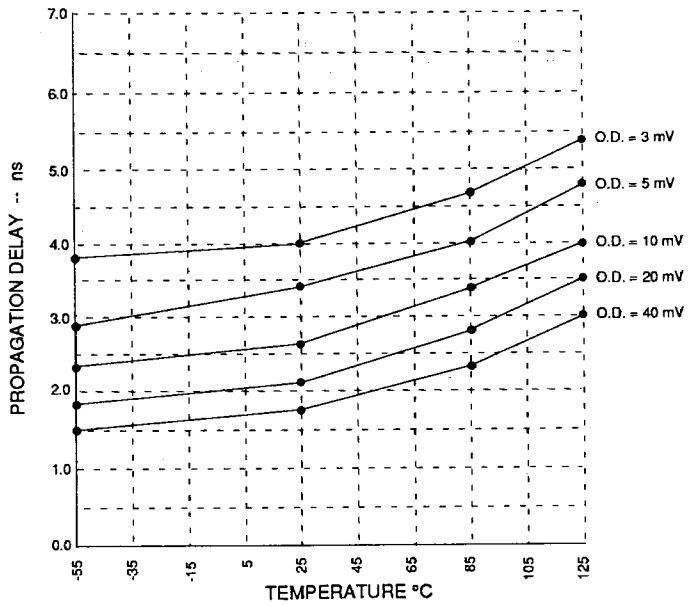
TYPICAL PERFORMANCE CURVES

Propagation Delay vs Overdrive



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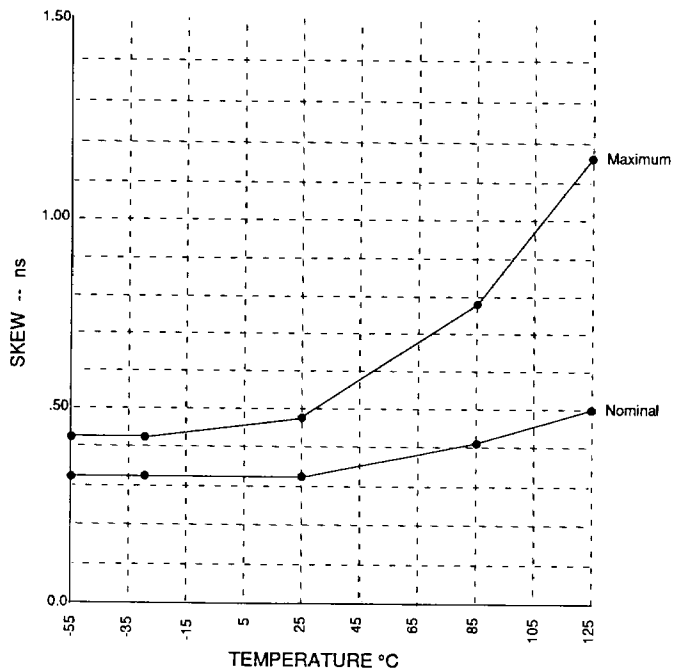
Propagation Delays vs Temperature also Overdrive



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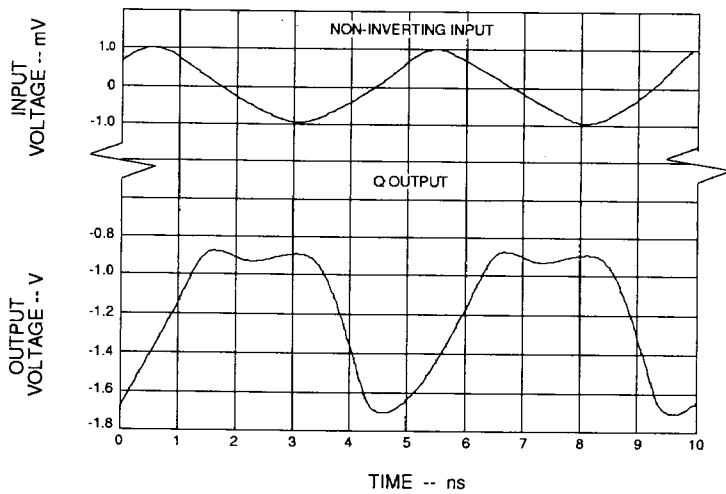
TYPICAL PERFORMANCE CURVES (Cont'd.)

Skew vs Temperature



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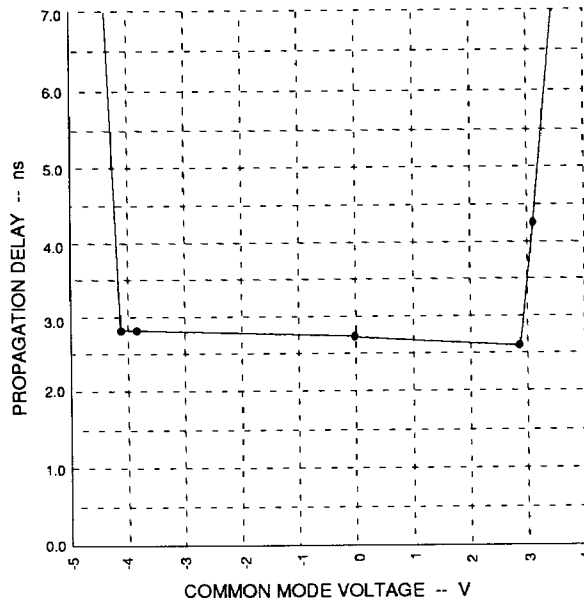
Response to 200-MHz Sine Wave



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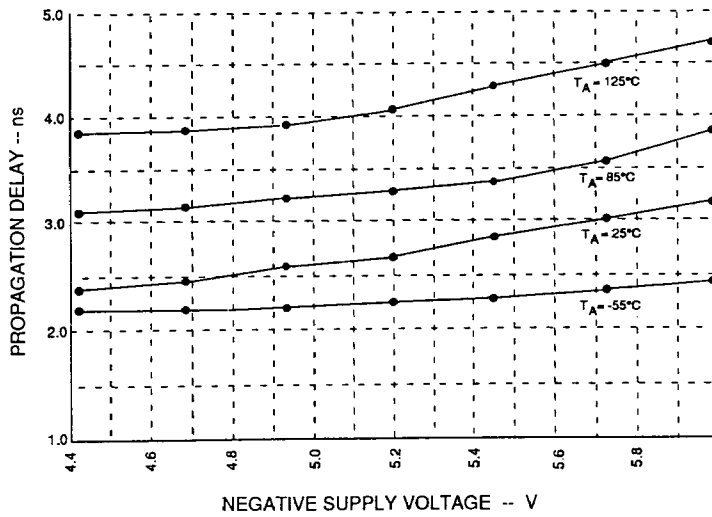
TYPICAL PERFORMANCE CURVES (Cont'd.)

Propagation Delay vs VCM



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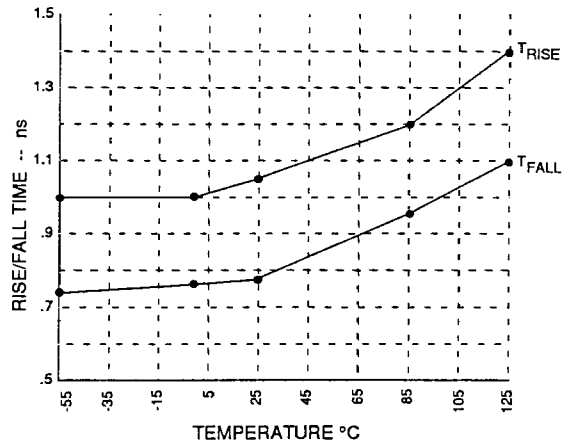
Propagation Delay vs V-



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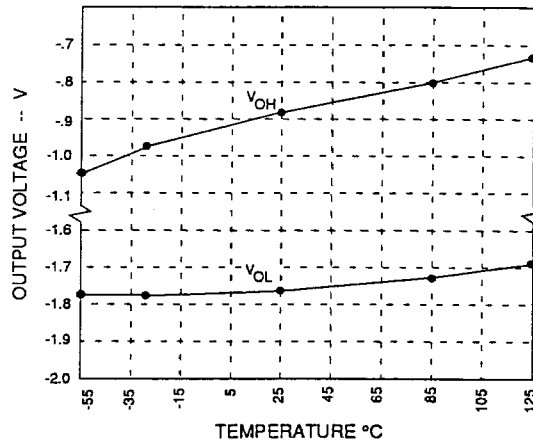
TYPICAL PERFORMANCE CURVES (Cont'd.)

Output Rise and Fall vs Temperature



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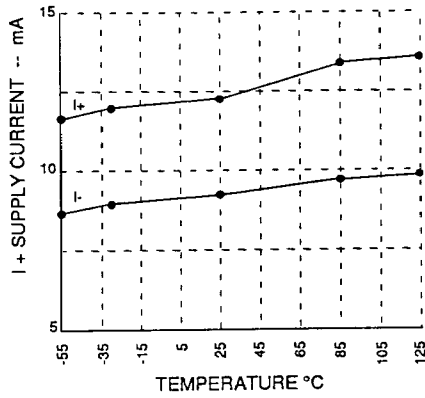
Output Voltage vs Temperature



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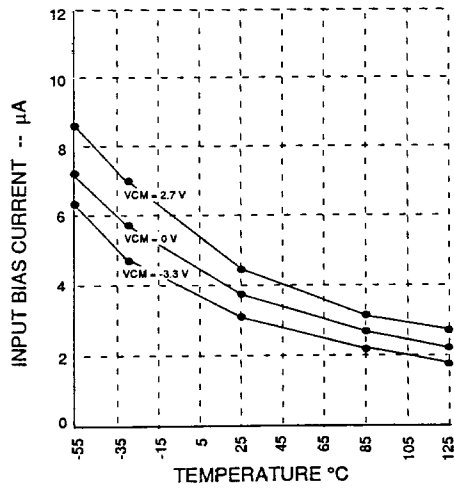
TYPICAL PERFORMANCE CURVES (Cont'd.)

Supply Currents vs Temperature



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Input Bias Current vs Temperature



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